

#### US005910839A

**Patent Number:** 

## United States Patent [19]

### Erskine

[45] **Date of Patent:** \*Jun. 8, 1999

# [54] WHITE LIGHT VELOCITY INTERFEROMETER

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[\*] Notice: This patent is subject to a terminal dis-

claimer.

[21] Appl. No.: 08/818,020

[22] Filed: Mar. 14, 1997

#### Related U.S. Application Data

[63] Continuation of application No. 08/597,082, Feb. 5, 1996, Pat. No. 5,642,194.

[51] Int. Cl.<sup>6</sup> ...... G01B 9/02

#### [56] References Cited

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Gidon et al., Multiple-line laser Doppler velocimetry, Jun. 1, 1988, vol. 27, No. 11, Applied Optics, pp. 2315–2319.

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#### [57] ABSTRACT

[11]

The invention is a technique that allows the use of broadband and incoherent illumination. Although denoted white light velocimetry, this principle can be applied to any wave phenomenon. For the first time, powerful, compact or inexpensive sources can be used for remote target velocimetry. These include flash and arc lamps, light from detonations, pulsed lasers, chirped frequency lasers, and lasers operating simultaneously in several wavelengths. The technique is demonstrated with white light from an incandescent source to measure a target moving at 16 m/s.

#### 87 Claims, 14 Drawing Sheets

